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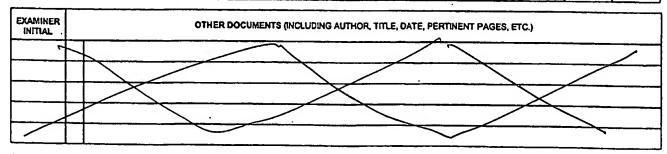
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SHEET 1 OF 1 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. ASMEX.387A FORM PTO-1449 APPLICATION NO. . 10/074,534 DEFORMATION DISCLOSURE STATEMENT BY APPLICANT APPLICANT Michael A. Todd 2 8 2004 (USE) SEVERAL SHEETS IF NECESSARY) FILING DATE February 11, 2002 GROUP . 2812

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